Power MOSFET

-20 V, -4.1 A, μCool™ Dual P-Channel, 2x2 mm WDFN Package

Features

- WDFN Package Provides Exposed Drain Pad for Excellent Thermal Conduction
- 2x2 mm Footprint Same as SC-88
- Lowest R_{DS(on)} Solution in 2x2 mm Package
- 1.8 V R_{DS(on)} Rating for Operation at Low Voltage Gate Drive Logic Level
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- Bidirectional Current Flow with Common Source Configuration
- This is a Pb-Free Device

Applications

- Optimized for Battery and Load Management Applications in Portable Equipment
- Li-Ion Battery Charging and Protection Circuits
- High Side Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-20	V
Gate-to-Source Voltage	je		V_{GS}	±8.0	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	-3.3	Α
Current (Note 1)	State	T _A = 85°C		-2.4	
	t ≤ 5 s	T _A = 25°C		-4.1	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P_{D}	1.5	W
	t ≤ 5 s			2.3	
Continuous Drain		T _A = 25°C	I _D	-2.3	Α
Current (Note 2)	Steady	T _A = 85°C		-1.6	
Power Dissipation (Note 2)	State	T _A = 25°C	P_{D}	0.71	W
Pulsed Drain Current	t _p =	10 μs	I _{DM}	-20	Α
Operating Junction and Storage Temperature			T_J , T_{STG}	–55 to 150	°C
Source Current (Body Diode) (Note 2)			IS	-1.9	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

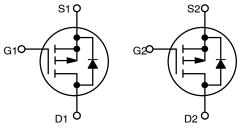
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm², 2 oz Cu.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX (Note 1)
	100 mΩ @ -4.5 V	
–20 V	135 mΩ @ –2.5 V	-4.1 A
	200 mΩ @ -1.8 V	



P-CHANNEL MOSFET

P-CHANNEL MOSFET



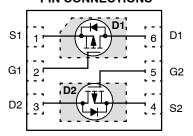
JD = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJD3115PT1G	WDFN6 (Pb-Free)	3000/Tape & Reel
NTLJD3115PTAG	WDFN6 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
SINGLE OPERATION (SELF-HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ hetaJA}$	83	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	177	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{ heta JA}$	54	
DUAL OPERATION (EQUALLY HEATED)			
Junction-to-Ambient - Steady State (Note 3)	$R_{ heta JA}$	58	
Junction-to-Ambient - Steady State Min Pad (Note 4)	$R_{ heta JA}$	133	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{ hetaJA}$	40	

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

$\textbf{MOSFET ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

OFF CHARACTERISTICS Drain-to-Source Breakdown Voltage Temperature Coefficient V(gR)pSS/T _J V _{OS} = 0 V, I _D = -250 µA -20 N V Drain-to-Source Breakdown Voltage Temperature Coefficient V _{OS} = 0 V, I _D = -250 µA, Ref to 25°C 9,95 mV/°C Gate To-Source Leakage Current I _{DSS} V _{DS} = 16 V, V _{OS} = 0 V T _J = 25°C 1 - 1.0 µA Gate Threshold Voltage V _{OS} = 16 V, V _{OS} = 0 V T _J = 85°C 1 - 1.0 µA ON CHARACTERISTICS (Note 5) Gate Threshold Voltage V _{OS} (TH) V _{OS} = V _{OS} , I _D = -2.50 µA -0.4 -0.7 -1.0 V Mogative Gate Threshold V _{OS} (TH) V _{OS} = -4.5, I _D = -2.0 A 7.5 100 mV/°C Drain-to-Source On-Resistance R _{DS} (m) V _{OS} = -4.5, I _D = -2.0 A 7.5 100 mC Forward Transconductance R _S (S) V _{OS} = -4.5, I _D = -2.0 A 6.0 1.50 2.00 CHARGES, CAPACITANCES AND GATE RESISTANCE V _{OS} = -4.5, I _D = -2.0 A 6.0 8.0 S CHARGES, CAPACITANCES AND GATE RESISTANCE	Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
District - Source Breakdown Voltage Viginjoss/Tij In = -250 μA, Rief to 25°C 9.95 m//°C morperature Coefficient 1.05 Viginios Viginjos Viginios	OFF CHARACTERISTICS	1 -					<u> </u>	<u>I</u>
Drain-to-Source Breakdown Voltage Temperature Coefficient V(BR)DSS/TJ ID = -250 μA. Ref to ≥5°C 9.95 IM mV/C Zero Gate Voltage Drain Current IDSS VDS = -16 V, VGS = 0 V TJ = 25°C	Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = -250 μA		-20			V
Zero Gate Voltage Drain Current IDSS VDS = −16 V, VGS = 0 V TJ = 25°C						9.95		mV/°C
No contact N	Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			-1.0	μΑ
On Characteristics (Note 5) Oracle Threshold Voltage VGS(TH) VGS = VDS, ID = −250 μA −0.4 −0.7 −1.0 V Negative Gate Threshold Temperature Coefficient VGS(TH) VGS = VDS, ID = −2.0 A −0.4 −0.7 −1.0 V Negative Gate Threshold Temperature Coefficient VGS(TH) VGS = −4.5, ID = −2.0 A −0.4 −0.7 −1.0 V VGS = −2.5, ID = −2.0 A −0.1 −			$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$				-10	_
A contact A	Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V, } V_{GS} = \pm$	8.0 V			±100	nA
Negative Gate Threshold Temperature Coefficient	ON CHARACTERISTICS (Note 5)							
$ \begin{array}{ c c c c c } \hline \text{Temperature Coefficient} & & & & & & & & & & & & & & & & & & &$	Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = -2$	50 μΑ	-0.4	-0.7	-1.0	V
V _{SS} = −2.5, l _D = −2.0 A 101 135 V _{SS} = −1.8, l _D = −1.6 A 150 200 Forward Transconductance g _{FS} V _{DS} = −5.0 V, l _D = −2.0 A 6.0 S CHARGES, CAPACITANCES AND GATE RESISTANCE Input Capacitance C _{ISS} Output Capacitance C _{OSS} Reverse Transfer Capacitance C _{OSS} Reverse Transfer Capacitance C _{OSS} V _{SS} = −10 V Total Gate Charge Q _G (TOT) Total Gate Charge Q _G (TOT) Cate-to-Dource Charge Q _{GS} Gate-to-Drain Charge Q _{GD} Gate-to-Drain C		V _{GS(TH)} /T _J				2.44		mV/°C
$ V_{GS} = -1.8, \ _D = -1.6 \ A \\ V_{GS} = -1.8, \ _D = -1.6 \ A \\ V_{DS} = -5.0 \ V, \ _D = -2.0 \ A \\ A = 0.0 \ B = 0.0 \ B$	Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5, I_D = -4.5$	2.0 A		75	100	mΩ
Forward Transconductance g _{FS} V _{DS} = -5.0 V, I _D = -2.0 A 6.0 S CHARGES, CAPACITANCES AND GATE RESISTANCE Input Capacitance C _{ISS} V _{GS} = -5.0 V, I _D = -2.0 A 6.0 S Output Capacitance C _{ISS} V _{GS} = -0.0 V, I = 1.0 MHz, V _{DS} = -1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, V _{DS} = -10 V, I = 1.0 MHz, I =			V _{GS} = -2.5, I _D = -	2.0 A		101	135	
CHARGES, CAPACITANCES AND GATE RESISTANCE Input Capacitance C _{ISS} Output Capacitance C _{OSS} Reverse Transfer Capacitance C _{RSS} Total Gate Charge Q _{G(TOT)} Threshold Gate Charge Q _{G(TH)} Gate-to-Source Charge Q _{GS} Gate-to-Drain Charge Q _{GD} Gate Resistance R _G SWITCHING CHARACTERISTICS (Note 6) Turn-On Delay Time t _d (ON) Rise Time t _f Turn-Off Delay Time t _d (ON) Rise Time t _f Turn-Off Delay Time t _d (ON) Rise Time t _f V _{GS} = -4.5 V, V _{DD} = -5.0 V, I _D = -5.0 V, I _D = -1.0 A, R _G = 0.0 Ω Rise Time t _f Turn-Off Delay Time t _f V _{GS} = -4.5 V, V _{DD} = -1.0 V, I _D = -5.0			V _{GS} = -1.8, I _D = -	1.6 A		150	200	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Forward Transconductance	9 _{FS}	V _{DS} = -5.0 V, I _D = -2.0 A			6.0		S
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	CHARGES, CAPACITANCES AND GA	TE RESISTAN	CE			•		•
Reverse Transfer Capacitance Cass	Input Capacitance	C _{ISS}				531		pF
Reverse Transfer Capacitance Cass	Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ I}$	MHz,		91		1
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance	C _{RSS}	VDS = -10 V			56		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Q _{G(TOT)}				5.5	6.2	nC
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_D = -2.0 \text{ A}$			0.7		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-to-Source Charge	Q_{GS}				1.0		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-to-Drain Charge	Q_{GD}				1.4		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	R_{G}				8.8		Ω
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	SWITCHING CHARACTERISTICS (No	te 6)						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(ON)}				6.0		ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} =	–5.0 V,		11		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(OFF)}	$I_D = -1.0 \text{ A}, R_G = 0$	6.0 Ω		21]
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f				8.0		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(ON)}				6.0		ns
	Rise Time	t _r	V _{GS} = -4.5 V, V _{DD} =	–10 V,		12		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-Off Delay Time	t _{d(OFF)}	$I_D = -2.0 \text{ A}, R_G = 2.0 \Omega$			19		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f				6.0		
$V_{GS} = 0 \text{ V, } IS = -1.0 \text{ A} \\ \hline T_J = 125^{\circ}C \\ \hline Charge Time \\ \hline Discharge Time \\ \hline V_{GS} = 0 \text{ V, } d_{ SD}/d_t = 100 \text{ A}/\mu\text{s,} \\ I_S = -1.0 \text{ A} \\ \hline \end{bmatrix} 12.6 \\ \hline T_J = 125^{\circ}C \\ \hline 12.6 \\ \hline \end{bmatrix} 7.0 \\ \hline Discharge Time \\ \hline \end{bmatrix} $	DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Reverse Recovery Time t_{RR} Charge Time t_a $V_{GS} = 0 \text{ V, } d_{ISD}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -1.0 \text{ A}$ 12.6 7.0 $18 = -1.0 \text{ A}$	Forward Recovery Voltage	V _{SD}	V 0V 10 40A	T _J = 25°C		-0.75	-1.0	\/
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			v _{GS} = u v, lS = -1.0 A	T _J = 125°C		-0.64]
Discharge Time t_b $l_S = -1.0 \text{ A}$ 5.6	Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } d_{ISD}/d_t = 100 \text{ A/}\mu\text{s,} \ I_S = -1.0 \text{ A}$			12.6		
Discharge Time t_b $I_S = -1.0 \text{A}$ 5.6	Charge Time	t _a				7.0		ns
Reverse Recovery Time Q _{RR} 5.0 nC	Discharge Time	t _b				5.6		
	Reverse Recovery Time	Q _{RR}				5.0		nC

^{5.} Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES ($T_J = 25^{\circ}C$ unless otherwise noted)

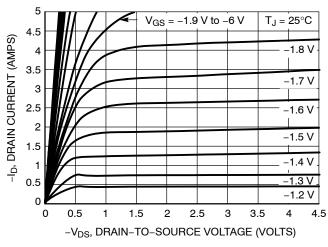
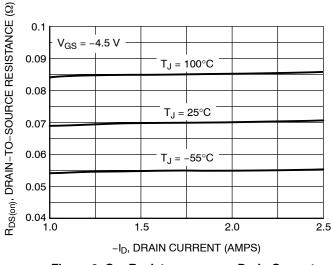


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



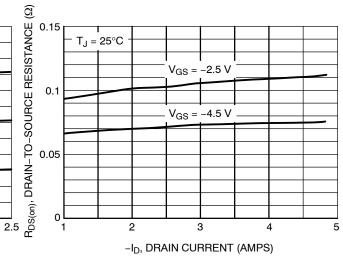
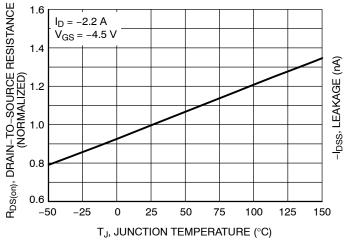


Figure 3. On-Resistance versus Drain Current

Figure 4. On-Resistance versus Drain Current and Gate Voltage



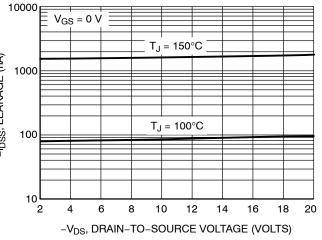
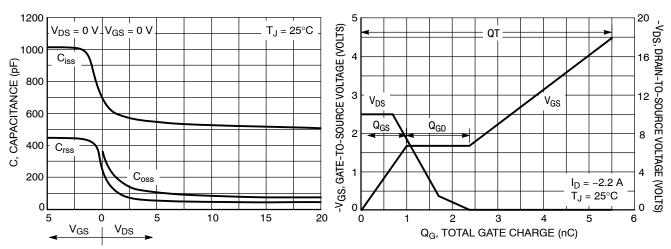


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL PERFORMANCE CURVES ($T_J = 25^{\circ}$ C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

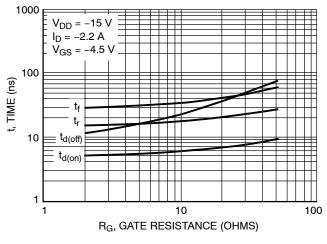


Figure 9. Resistive Switching Time Variation versus Gate Resistance

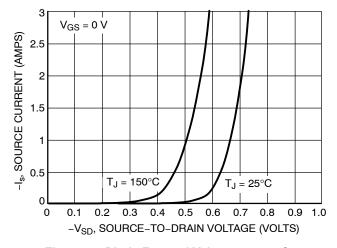


Figure 10. Diode Forward Voltage versus Current

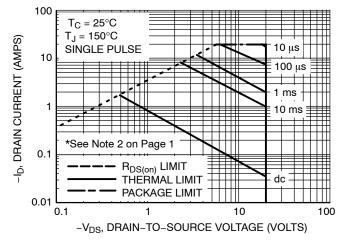


Figure 11. Maximum Rated Forward Biased Safe Operating Area

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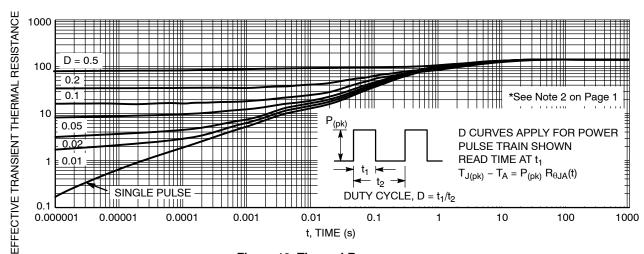
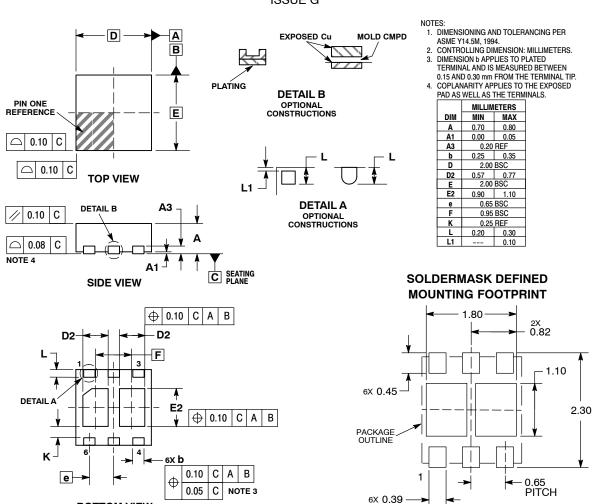


Figure 12. Thermal Response

PACKAGE DIMENSIONS

WDFN6, 2x2 CASE 506AN ISSUE G



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BOTTOM VIEW

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